ΗΙΟΚΙ

BATTERY TESTER Series

Measuring Battery Quality

Cells - Modules - Packs

Quality Testing Maintenance Inspections R & D

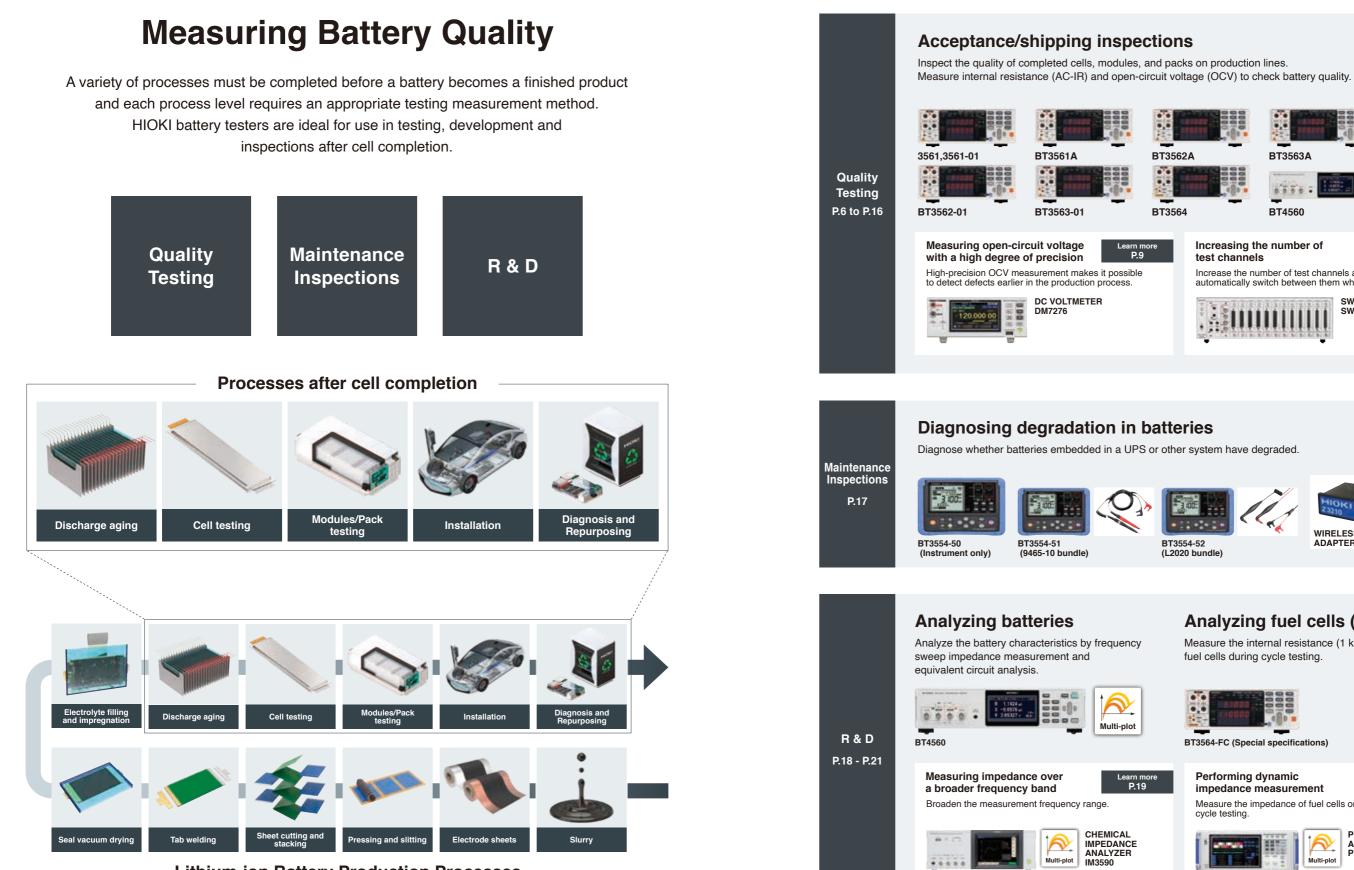








*1: BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01 only *2: BT3554-50, BT3554-51, BT3554-52 only



Lithium-ion Battery Production Processes







Battery tester lineup

		Acceptance/shipping inspections						
ation		Small cells for general purpose High speed sorting	Small cells for power motors Small packs of up to 60 V	Large cells for xEVs Mid-sized packs of up to 100 V	Large packs for xEVs Large packs of up to 300 V			
		3561, 3561-01	BT3561A	BT3562A	BT3563A			
			NEW	NEW	NEW			
e								
ent method		AC four-terminal method	AC four-terminal method	AC four-terminal method	AC four-terminal method			
ent frequency		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	1 kHz ±0.2 Hz			
t voltage		±22 V DC	±60 V DC	±100 V DC	±300 V DC			
ated voltage to ea	arth	±60 V DC	±60 V DC	±100 V DC	±300 V DC			
	3 mΩ	N/A	N/A	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA			
nce rement		N/A	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA			
					310.00 mΩ,10 μΩ, 10 mA			
enlav			, , ,	, , ,	3.1000 Ω,100 μΩ, 1 mA			
spiay, on,					31.000 Ω, 1 mΩ, 100 μA 310.00 Ω, 10 mΩ, 10 μA			
ement			, , , ,		· · · ·			
D. I	3 mΩ		, , , , , , , , , , , , , , , , , , ,	· · · · ·	3.1000 kΩ, 100 mΩ, 10 μA			
	ange 30 mO				±0.5% rdg ±10 dgt ±0.5% rdg ±5 dgt			
accuracy	range or more				6.000 00 V, 10 μV			
	-				N/A			
rement					60.000 0 V, 100 μV			
					N/A			
splav.					300.000 V, 1 mV			
on	1000 V	N/A	N/A	N/A	N/A			
Basic acc	uracy	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt	±0.01% rdg ±3 dgt			
time *1		3 ms	10 ms	10 ms	10 ms			
eriod *2	Ω or V	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms	4 ms, 12 ms, 35 ms, 150 ms			
	ΩV	7 ms, 23 ms, 69 ms, 252 ms	8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 ms	8 ms, 24 ms, 70 ms, 253 ms			
tal line resistance *1	^{*3} SENSE line	Ν/Α, Ν/Α, 20 Ω, 20 Ω	Ν/Α, 6.5 Ω, 30 Ω, 30 Ω	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω	6.5 Ω, 6.5 Ω, 30 Ω, 30 Ω			
on) , 30 mΩ, 300 mΩ, 3 Ω	SOURCE line	Ν/Α, Ν/Α, 50 Ω, 500 Ω	Ν/Α, 5.5 Ω, 15 Ω, 150 Ω	5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω	5.5 Ω, 5.5 Ω, 15 Ω, 150 Ω			
n al voltage nΩ or less, 300 mΩ,	3 Ω or more	N/A, 7 V, 7 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak	25 V, 7 V, 4 V peak			
CP/IP, 10BASE-T	(100BASE-TX)	N/A	YES	YES	YES			
C ^{*4} (Max. 38400 I	ops)	YES	YES	YES	YES			
		N/A	N/A	N/A	N/A			
		YES (3561-01 Only)	N/A	N/A	N/A			
	,	YES (36-pin)		YES	YES			
	o 3.1 V)	N/A	YES	YES	YES			
check		YES	YES	YES	YES			
, ,	,				YES			
	se output				YES			
					Hi/ IN/ Lo Max. 30,000			
a calculations				,	YES			
Э					2 to 16 times			
					126			
/ storage		400	400	400	400			
W [®] driver ^{'5}		YES	YES	YES	YES			
standards		Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A	Safety: EN61010 EMC: EN61326 Class A			
diated radio-frequ netic field	ency	Resistant "6	Resistant '6	Resistant '6	Resistant '6			
nducted	10 V	N/A	Resistant	Resistant	Resistant			
ncy netic field	3 V	Resistant	Resistant	Resistant	Resistant			
		YES	YES	YES	YES			
		N/A	YES	YES	YES			
s • Weight		215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)	215W × 80H × 295D mm (8.46W × 3.15H × 11.61D in) 2.4 kg (84.66 oz)			
	ent method ent frequency voltage ated voltage to ea ated voltage to ea ement play, on Basic accuracy ement accuracy ement aline resistance ¹ on 30 mΩ, 300 mΩ, 3 Ω mal voltage moritage Ω or less, 300 mΩ, 3 Ω mal voltage Ω or less, 300 mΩ, 300 mΩ, 3 Ω mal voltage Ω or less, 300 mΩ, 3 Ω mal voltage Ω or less, 300 mΩ, 300 m	ent method ent frequency voltage ated voltage to earth mce ement accuracy all and accuracy all	for general purpose High speed sorting 3361, 3561-01 association of the speed sorting aspeed sorting as	Small cells for general purpose High speed sorting Small cells for power motors Small packs of up to 60 v 3561, 3561-01 BT3561A net method int frequency AC four-terminal method 1 kHz d0 2 Hz 1 KHz 1 kHz d0 2 Hz net method int frequency 3 mQ 1 kHz d0 2 Hz 1 kHz d0 2 Hz voitage #22 V DC #60 V DC #60 V DC ated voitage to earth #60 V DC #60 V DC #60 V DC 30 mQ 31000 mQ, 10 µA, 10 mA 31000 mQ, 10 µA, 10 mA 31000 Q, 10 µA, 10 mA ated voitage to earth 30 mQ NA 31000 Q, 10 µA, 10 mA 31000 Q, 10 µA, 10 mA 30 mQ 31000 Q, 10 µA, 10 mA 31000 Q, 10 µA, 10 mA 31000 Q, 10 µA, 10 mA 30 Q NA 31000 Q, 10 µA, 10 mA 31000 Q, 10 µA, 10 mA 30 Q NA 31000 Q, 10 µA, 10 mA 31000 Q, 10 µA accuraty 30Q NA 31000 Q, 10 µA accuraty 40 V NA 31000 Q, 10 µA particle Ma NA NA accuraty 30Q V NA NA accuraty <td>Small cells or general purpose (might speed sorting) Small cells for power motors (might speed sorting) Large cells for xEVy Mid-lazod packs of up to 100 V static cells or general purpose (might speed sorting) Small cells (might speed sorting) BT3561A BT3562A static cells or general purpose (might speed sorting) AC four-terminal method 1 kHz a0 2 Hz AC four-terminal method 1 kHz a0 2 Hz</td>	Small cells or general purpose (might speed sorting) Small cells for power motors (might speed sorting) Large cells for xEVy Mid-lazod packs of up to 100 V static cells or general purpose (might speed sorting) Small cells (might speed sorting) BT3561A BT3562A static cells or general purpose (might speed sorting) AC four-terminal method 1 kHz a0 2 Hz AC four-terminal method 1 kHz a0 2 Hz			

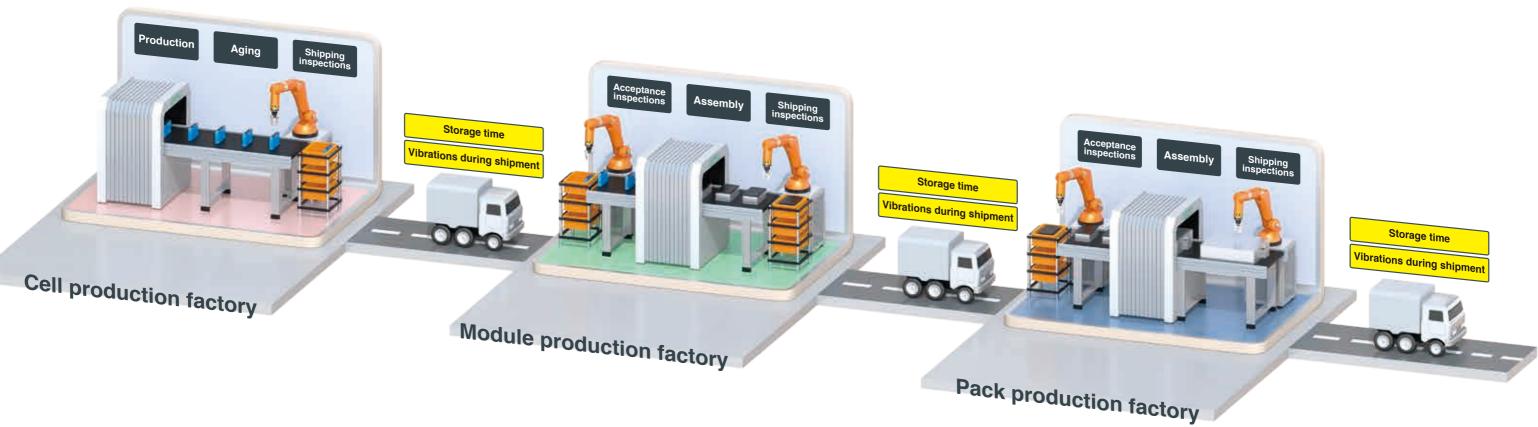
*1: Typical value *2: When the power supply frequency is 60 Hz *3: Total line resistance = wiring resistance + contact resistance + DUT resistance *4: Available as printer I/F *5: LabVIEW® Driver is a registered trademark of National Instruments Corporation *6: Test conditions were 80 MHz to 1 GHz at 10 V/m and 1 GHz to 6 GHz at 3 V/m, all at 80% AM *7: Canadian Standards Assosiation

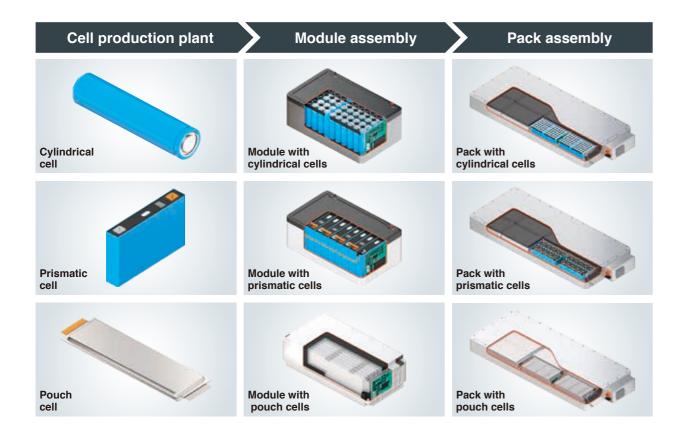
			Acceptance/ship	ping inspections	R & D	Maintenance
Applicatio	n		Extra large packs for xEV, ESS 1000 V high voltage model	GP-IB model	Cells or packs up to 20 V Degree of deterioration for reuse	Large-scale UPS
Model			BT3564	BT3562-01 BT3563-01	BT4560	BT3554-50 ^{*10} BT3554-51 ^{*10} BT3554-52 ^{*10}
			Special specifications for FCs available		Special specifications for 10 kHz available	NEW
Appearance					(Refer to P.19)	
Measurement me	thod		AC four-terminal method	AC four-terminal method	AC four-terminal pair method	AC four-terminal method
Measurement free	quency		1 kHz ±0.2 Hz	1 kHz ±0.2 Hz	0.10 Hz to 1050 Hz	1 kHz ±80 Hz
Rated input voltag	ge		±1000 V DC	BT3562-01: ±70 V DC BT3563-01: ±300 V DC	±5 V DC Special specification supports up to ±20 V DC	±60 V DC
Maximum rated v	oltage to ear	th	±1000 V DC	BT3562-01: ±60 V DC BT3563-01: ±300 V DC	SOURCE-H, SENSE-H: ±5 V DC SOURCE-L, SENSE-L: 0 V DC	±60 V DC
		3 mΩ	3.1000 mΩ, 0.1 μΩ, 100 mA	3.1000 mΩ, 0.1 μΩ, 100 mA	Resistance (R)	
Resistance		30 mΩ	31.000 mΩ, 1 μΩ, 100 mA	31.000 mΩ, 1 μΩ, 100 mA	3.6000 mΩ, 0.1 μΩ, 1.5 A	Resistance (R)
measuremen ranges	t	300 mΩ	310.00 mΩ,10 μΩ, 10 mA	310.00 mΩ,10 μΩ, 10 mA	12.0000 mΩ, 0.1 μΩ, 500 mA 120.000 mΩ, 1 μΩ, 50 mA	3.100 mΩ, 1 μΩ, 160 mA
, i i i i i i i i i i i i i i i i i i i		3Ω	3.1000 Ω,100 μΩ, 1 mA	3.1000 Ω,100 μΩ, 1 mA	[The number of waveforms] Frequency: FAST, MEDIUM, SLOW	31.00 mΩ, 10 μΩ, 160 mÅ 310.0 mΩ, 100 μΩ, 16 mÅ
Max. display, resolution,		30 Ω	31.000 Ω, 1 mΩ, 100 μΑ	31.000 Ω, 1 mΩ, 100 μΑ	0.10 Hz to 66 Hz: 1 wave, 2 waves, 8 waves	3.100 Ω, 1 mΩ, 1.6 mA
e measurement		300 Ω	310.00 Ω, 10 mΩ, 10 μΑ	310.00 Ω, 10 mΩ, 10 μA	67 Hz to 250 Hz: 2 waves, 8 waves, 32 waves 260 Hz to 1050 Hz: 8 waves, 32 waves, 128 waves	[Basic accuracy] ±1.0% rdg ±8 dgt
current		3 kΩ 3 mΩ	3.1000 kΩ, 100 mΩ, 10 μA	3.1000 kΩ, 100 mΩ, 10 μA	Reactance (X)	(3 m Ω range) ±0.8% rdg ±6 dgt
	Basic accuracy	30 mO	±0.5% rdg ±10 dgt *8	±0.5% rdg ±10 dgt	±3.6000 mΩ, 0.1 μΩ, 1.5 A ±12.0000 mΩ, 0.1 μΩ, 500 mA	$\pm 0.8\%$ rdg ± 0 dgi (30 m Ω range or more)
Voltage measuremen	accuracy	ange or more 6 V	±0.5% rdg ±5 dgt *8 N/A	±0.5% rdg ±5 dgt 6.000 00 V, 10 μV	±120.000 mΩ, 1 μΩ, 50 mA	Voltage (V)
Se Voltage		10 V	9.999 99 V, 10 μV	N/A	Impedance (Ζ) 3.6000 mΩ, 0.1 μΩ, 1.5 A	6.000 V, 1 mV
measuremen	t	60 V	N/A	60.000 0 V, 100 μV	12.0000 mΩ, 0.1 μΩ, 500 mA	60.00 V, 10 mV [Basic accuracy]
ranges		100 V	99.999 9 V, 100 μV	N/A	120.000 mΩ, 1 μΩ, 50 mA Phase angle (θ)	±0.08% rdg ±6 dgt
Max. display,		300 V	N/A	300.000 V, 1 mV (BT3563-01 only)	±180.000°, 0.001° [Basic accuracy] Refer to P.19	Temperature (°C)
resolution						
resolution		1000 V	1100.00 V, 1 mV '9	N/A	Voltage (V)	-10.0°C to 60.0°C, 0.1°C
resolution	Basic accu		1100.00 V, 1 mV ⁻⁹ ±0.01% rdg ±3 dgt ⁻⁸	N/A ±0.01% rdg ±3 dgt	Voltage (V) ±5.10000 V, 10 μV	-10.0°C to 60.0°C, 0.1°C
Response time *1	Basic accu		,		Voltage (V) ±5.10000 V, 10 μV [Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period]	-10.0°C to 60.0°C, 0.1°C
Response time '1 Sampling period '	2	racy Ω or V	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms	Voltage (V) ±5.10000 V, 10 µV [Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW	1.6 s N/A
Response time *1	2	racy	±0.01% rdg ±3 dgt '8 700 ms	±0.01% rdg ±3 dgt 10 ms	Voltage (V) ±5.10000 V, 10 µV [Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C)	1.6 s
Response time ^{*1} Sampling period [*] EX.FAST, FAST, ME Allowable total line (error detection)	¹² DIUM, SLOW resistance ^{11 13}	Ω or V ΩV SENSE line	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms	Voltage (V) ±5.10000 V, 10 µV [Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ¹¹ 3	1.6 s N/A 100 ms N/A
Response time ^{*1} Sampling period [*] EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ	² DIUM, SLOW resistance ^{*1 *3} , 300 mΩ, 3 Ω	racy Ω or V ΩV	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms N/A, 28 ms, 74 ms, 359 ms	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ	1.6 s N/A 100 ms
Response time ^{*1} Sampling period [*] EX.FAST, FAST, ME Allowable total line (error detection)	¹² DIUM, SLOW resistance ^{11 '3} , 300 mΩ, 3 Ω Itage	Ω or V ΩV SENSE line SOURCE line	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms N/A, 28 ms, 74 ms, 359 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω	Voltage (V) ±5.10000 V, 10 µV [Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1°3 (error detection)	1.6 s N/A 100 ms N/A
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP,	² DIUM, SLOW resistance '1 '3 , 300 mΩ, 3 Ω Itage Joss, 300 mΩ, 3 10BASE-T/1	$ \begin{array}{c} \Omega \text{ or V} \\ \overline{\Omega V} \\ \hline SENSE line \\ \hline SOURCE line \\ \overline{\Omega \text{ or more}} \\ \hline 00BASE-TX) \end{array} $	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms N/A, 28 ms, 74 ms, 359 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A	Voltage (V) \pm 5.10000 V, 10 μ V [Basic accuracy] \pm 0.0035% rdg \pm 5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mQ, 10 mQ, 100 mQ SENSE line: 10 Ω , 15 Ω , 50 Ω SOURCE line: 1.5 Ω , 4 Ω , 45 Ω N/A	1.6 s N/A 100 ms N/A N/A 5 V max ∙ USB
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ⁻⁴ (M	² DIUM, SLOW resistance '1 '3 , 300 mΩ, 3 Ω Itage Joss, 300 mΩ, 3 10BASE-T/1	$ \begin{array}{c} \Omega \text{ or V} \\ \overline{\Omega V} \\ \hline SENSE line \\ \hline SOURCE line \\ \overline{\Omega \text{ or more}} \\ \hline 00BASE-TX) \end{array} $	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES	1.6 s N/A 100 ms N/A N/A 5 V max • USB • Wireless communications
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ⁻⁴ (M USB	² DIUM, SLOW resistance '1 '3 , 300 mΩ, 3 Ω Itage Joss, 300 mΩ, 3 10BASE-T/1	$ \begin{array}{c} \Omega \text{ or V} \\ \overline{\Omega V} \\ \hline SENSE line \\ \hline SOURCE line \\ \overline{\Omega \text{ or more}} \\ \hline 00BASE-TX) \end{array} $	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES	1.6 s N/A 100 ms N/A N/A 5 V max ∙ USB
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ¹⁴ (M USB GP-IB	² DIUM, SLOW resistance '1 '3 , 300 mΩ, 3 Ω ltage uss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp	racy $ \frac{\Omega \text{ or } V}{\Omega V} $ SENSE line SOURCE line $ \Omega \text{ or more} $ 00BASE-TX) ps)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES	Voltage (V) \pm 5.10000 V, 10 μ V [Basic accuracy] \pm 0.0035% rdg \pm 5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mQ, 10 mQ, 100 mQ SENSE line: 10 Ω , 15 Ω , 50 Ω SOURCE line: 1.5 Ω , 4 Ω , 45 Ω N/A YES YES N/A	1.6 s N/A 100 ms N/A N/A 5 V max • USB • Wireless communications (*when Z3210 installed)
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ⁻⁴ (M USB	² DIUM, SLOW resistance ^{11 ·3} , 300 mΩ, 3 Ω Itage iss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in	racy Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) os) terface)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communication (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ¹⁴ (M USB GP-IB EXT I/O (37-p	² DIUM, SLOW resistance ^{11 ·3} , 300 mΩ, 3 Ω Itage iss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in <u>(DC 0 V to 5</u>)	racy Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) os) terface)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1"3 (error detection) SmQ, 10 mQ, 100 mQ SENSE line: 10 Q, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES N/A YES N/A YES N/A YES	1.6 s N/A 100 ms N/A N/A 5 V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function
Response time ¹¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ¹⁴ (M USB GP-IB EXT I/O (37-p Analog output	² DIUM, SLOW resistance ^{11 '3} , 300 mΩ, 3 Ω Itage iss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in <u>(DC 0 V to 5</u>	racy Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1'3 (error detection) S mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES N/A YES N/A YES N/A YES N/A YES N/A	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto memory function • Auto memory function • Measurement Navigator (When using Z3210,
Response time ¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ¹⁴ (M USB GP-IB EXT I/O (37-p Analog output Contact check	² DIUM, SLOW resistance ¹¹ ³³ , 300 mΩ, 3 Ω Itage sss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 (c) c) c) c) c) c) c) c) c) c) c) c) c)	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1"3 (error detection) S mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto memory function • Measurement Navigator
Response time '' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme	² DIUM, SLOW resistance ¹¹ ³³ , 300 mΩ, 3 Ω Itage sss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 (c) c) c) c) c) c) c) c) c) c) c) c) c)	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 200 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1"3 (error detection) SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES N/A YES N/A YES N/A	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto memory function • Measurement Navigator (When using Z3210, GENNECT Cross · Voice guide output) • Auto power-off
Response time ^{'1} Sampling period ['] EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mQ, 30 mQ Open terminal vo Ranges: 30 mQ or le LAN (TCP/IP, RS-232C ^{'4} (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calo	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω Itage iss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in c (DC 0 V to 3 c current pulse	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy] ±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1°3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES YES N/A YES Hi/ N/A YES Hi/ IN/ Lo Hi/ IN/ Lo N/A	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross · Voice guide output)
Response time ^{'1} Sampling period ['] EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 30 mQ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω Itage iss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in c (DC 0 V to 3 c current pulse	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ^{-1, 3} (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto memory function • Auto-hold function • Auto power-off • Tablet app (GENNECT Cross) • PC app
Response time ^{'1} Sampling period ['] EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 30 mQ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay Average	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω Itage biss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 c) current pulse culations	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ^{-1,13} (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES Hi/ IN/ L0 N/A YES 1 to 99 times	
Response time '' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 30 mΩ or le Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay Average Panel saving/I	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω Itage biss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 cont (±1000 cc current pulse culations	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ⁻¹⁺³ (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES 1 to 99 times 126	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/ WARNING/ FAIL)
Response time '' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 30 mQ or le Comparison of the terminal vo Ranges: 30 mQ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay Average Panel saving/I Memory stora	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω Itage biss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 cont (±1000 cc current pulse culations	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ⁺¹⁺³ (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES 10 YES 11 to 99 times 126 N/A	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/ WARNING/ FAIL)
Response time '' Sampling period ' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustment Comparator Statistical calc Delay Average Panel saving/I Memory stora LabVIEW [®] driv	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω ltage uss, 300 mΩ, 3 Ω ltage uss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 current pulse current pulse current pulse culations loading ge ver ¹⁵	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES Hi/ IN/ L0 Max. 30,000 YES 2 to 16 times 126 400 N/A	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ L0 Max. 30,000 YES 2 to 16 times 126 400 YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ⁺¹⁺³ (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross) • Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/WARNING/ FAIL) • Excel® Direct Input functii (When using Z3210)
Response time '' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 30 mQ or le Comparison of the terminal vo Ranges: 30 mQ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay Average Panel saving/I Memory stora	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω ltage uss, 300 mΩ, 3 Ω ltage uss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 current pulse current pulse current pulse culations loading ge ver ¹⁵	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ⁺¹⁺³ (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES 10 YES 11 to 99 times 126 N/A	1.6 s N/A 100 ms N/A N/A S V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Ore) • Comparator function (PASS/ WARNING/ FAIL) • Excel® Direct Input function (When using Z3210) Safety: EN61010
Response time '' Sampling period ' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustment Comparator Statistical calc Delay Average Panel saving/I Memory stora LabVIEW [®] driv	² DIUM, SLOW resistance ^{11 '3} , 300 mΩ, 3 Ω Itage iss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in in Handler in in (DC 0 V to) c current pulse culations loading ge ver '5 ards radio-freque	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V) punts) e output	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 YES Safety: EN61010	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance ⁺¹⁺³ (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES Hi/ IN/ Lo N/A YES 1 to 99 times 126 N/A YES Safety: EN61010	1.6 s N/A 100 ms N/A N/A S V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Measurement Navigator (When using Z3210, GENNECT Cross : Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Ore) • Comparator function (PASS/ WARNING/ FAIL) • Excel® Direct Input function (When using Z3210) Safety: EN61010
Response time '' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mQ, 30 mQ Open terminal vo Ranges: 30 mQ or le LAN (TCP/IP, RS-232C'4 (M USB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calo Delay Average Panel saving/I Memory stora LabVIEW® driv Applicable standa Effect of radiated electromagnetic f	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω ltage bss, 300 mΩ, 3 Ω ltage bss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in c (DC 0 V to 3 c (DC 0 V	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V) punts) e output	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω 2 Ω, 15 Ω 2 Ω, 15 Ω, 15 Ω 2 Ω, 15 Ω	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1"3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A	1.6 s N/A 100 ms N/A N/A SVmax • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function (Up to 6000 data) • Auto memory function • Measurement Navigator (When using Z3210, GENNECT Cross) • Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/ WARNING/ FAIL) • Excel [®] Direct Input functi (When using Z3210) Safety: EN61010 EMC: EN61326 Class E
Response time '1 Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 30 mΩ or le Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C'4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay Average Panel saving/I Memory stora LabVIEW [®] drin Applicable standa	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω ltage sss, 300 mΩ, 3 Ω ltage sss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 c current pulse current	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS) terface) 3.1 V) bunts) e output	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant ^{*8}	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 15 Ω 2 Ω, 15 Ω 2 Ω, 15 Ω, 15 Ω 2 Ω, 15 Ω	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1°3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES 1to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '8	1.6 s N/A 100 ms N/A N/A SV max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto-hold function • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Ore) • Comparator function (PASS/ WARNING/ FAIL) • Excel® Direct Input function (When using Z3210) Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m)
Response time ¹ Sampling period ¹ EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C ¹⁴ (M USB EXT I/O (37-p Analog output Contact check Zero adjustme Measurement Comparator Statistical calc Delay Average Panel saving/I Memory stora LabVIEW [®] drir Applicable standa Effect of radiated electromagnetic f	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω ltage sss, 300 mΩ, 3 Ω ltage sss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 c current pulse current	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES YES YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant ^{*8} N/A Resistant	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω, 2 Ω, 15 Ω, 150 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES YES YES YES	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance '1'3 (error detection) 3 mQ, 10 mQ, 100 mQ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES N/A YES N/A YES N/A YES N/A YES Hi/ IN/ LO N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant '6 N/A Resistant	1.6 s N/A 100 ms N/A N/A S V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto-hold function • Auto nomory function • Auto-hold function • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/WARNING/ FAIL) • Excel® Direct Input function (When using Z3210) Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m) N/A
Response time '' Sampling period ' Sampling period ' EX.FAST, FAST, ME Allowable total line (error detection) Ranges: 3 mΩ, 30 mΩ Open terminal vo Ranges: 30 mΩ or le LAN (TCP/IP, RS-232C '4 (M USB GP-IB EXT I/O (37-p Analog output Contact check Zero adjustment Comparator Statistical calc Delay Average Panel saving/I Memory stora LabVIEW [®] driv Applicable standa Effect of radiated electromagnetic f	² DIUM, SLOW resistance ¹¹ ¹³ , 300 mΩ, 3 Ω ltage sss, 300 mΩ, 3 Ω ltage sss, 300 mΩ, 3 10BASE-T/1 lax. 38400 bp in Handler in (DC 0 V to 3 c current pulse current	Ω or V ΩV SENSE line SOURCE line Ω or more 00BASE-TX) DS)	±0.01% rdg ±3 dgt ^{*8} 700 ms N/A, 12 ms, 35 ms, 253 ms 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 3 Ω, 3 Ω, 20 Ω, 20 Ω 25 V, 7 V, 4 V peak N/A YES N/A YES YES YES YES YES Hi/ IN/ Lo Max. 30,000 YES 2 to 16 times 126 400 N/A Safety: EN61010 EMC: EN61326 Class A Resistant ^{*6} N/A	±0.01% rdg ±3 dgt 10 ms 4 ms, 12 ms, 35 ms, 150 ms 8 ms, 24 ms, 70 ms, 253 ms 2 Ω, 2 Ω, 15 Ω, 15 Ω 2 Ω,	Voltage (V) ±5.10000 V, 10 μV [Basic accuracy]±0.0035% rdg ±5 dgt [Sampling period] FAST, MEDIUM, SLOW 0.1 s, 0.4 s, 1.0 s Temperature (°C) -10.0°C to 60.0°C, 0.1°C Allowable total line resistance "1"3 (error detection) 3 mΩ, 10 mΩ, 100 mΩ SENSE line: 10 Ω, 15 Ω, 50 Ω SOURCE line: 1.5 Ω, 4 Ω, 45 Ω N/A YES 1 to 99 times 126 N/A YES Safety: EN61010 EMC: EN61326 Class A Resistant "6 N/A	1.6 s N/A 100 ms N/A N/A S V max • USB • Wireless communications (*when Z3210 installed) • Memory function (Up to 6000 data) • Auto memory function • Auto memory function • Measurement Navigator (When using Z3210, GENNECT Cross) • Voice guide output) • Auto power-off • Tablet app (GENNECT Cross) • PC app (GENNECT One) • Comparator function (PASS/ WARNING/ FAIL) • Excel [®] Direct Input functi (When using Z3210) Safety: EN61010 EMC: EN61326 Class E Resistant (3 V/m) N/A

*8: Average function: When set to ON 4 times *9: Resolution 10 mV for 1000.00 V or more *10: -50: Instrument only, -51: 9465-10 bundle, -52: L2020 bundle *11: Zero-adjustment range R: ±0.1000 mΩ (3 mΩ range), ±0.3000 mΩ (10 mΩ range), ±3.000 mΩ (100 mΩ range), X: ±1.5000 mΩ (Common for all ranges), V: ±0.10000 V

6

Measuring battery performance and safety





Measuring battery performance and safety using internal resistance (AC-IR) and open-circuit voltage (OCV)

Testing plays an important role in production processes by allowing plants to manufacture safe, high-performance batteries. During shipping and acceptance inspections, technicians assess battery performance by measuring internal resistance and safety by measuring open-circuit voltage.

Our Battery testers meet these needs...

"We want to manufacture batteries with stable performance."

"We want to manufacture highly safe batteries."

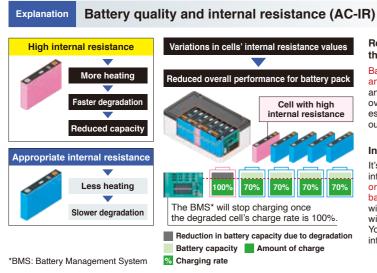
Assembly process (from cell batteries to pack batteries)

Cells produced at the cell production factory are shipped to the module production factory after undergoing a shipping inspection. Since factors such as vibrations during shipment and even the passage of time can cause defects, batteries undergo an acceptance inspection before being assembled into modules and packs.

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Measuring battery performance and safety

Manufacturing batteries with stable performance



Relationship between the internal resistance and the decline of battery cell capacity

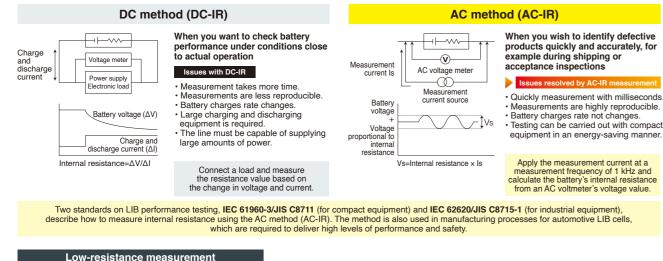
Battery cells with high internal resistance tend to generate more heat and degrade faster. When cells degrade, their capacity declines, and their internal resistance rises. Internal resistance also changes over time or as a consequence of vibrations during shipment. It's essential to eliminate cells with high internal resistance by carrying out an inspection each time cells are shipped or received.

Internal resistance and battery pack performance

It's important that all the cells in a given battery pack have uniform internal resistance. If one or more cells have high internal resistance or have degraded, they will become a bottleneck and limit the battery pack's capacity. Moreover, the battery pack's performance will rapidly decline as the BMS* attempts to protect degraded cells with reduced capacity from overcharging and over-discharging. You can improve battery cell quality by selecting cells with uniform internal resistance so that they will degrade uniformity.

Internal resistance measurement (AC-IR measurement) 3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

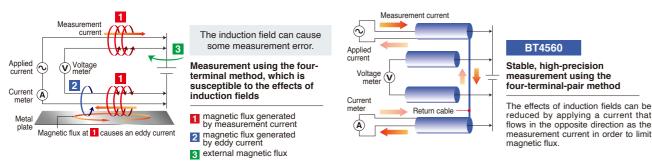
There are two methods for measuring a battery's internal resistance: the AC method and the DC method. Resistance values are known as AC-IR when measured using the AC method, and as DC-IR when measured using the DC method. AC-IR and DC-IR have a complementary relationship, and it's recommended to choose the one that best suits your application, or to carry out both measurements. HIOKI battery testers can perform 4-terminal AC-IR measurement.



$(1 m\Omega and lower)$ for large batteries

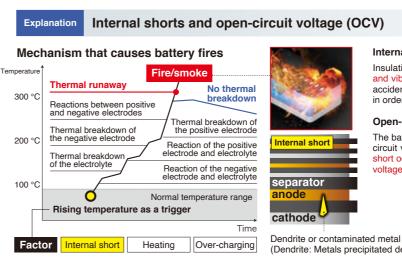
BT4560

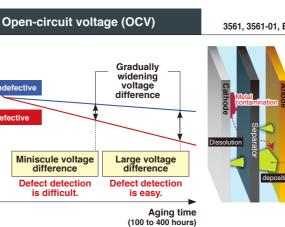
The larger the battery, the lower its internal resistance. Large batteries used in automobiles and infrastructure applications sometimes have internal resistance values of less than 1 mΩ. The BT4560's four-terminal-pair measurement method, which reduces the effects of induction fields, is an optimal solution for accurately measuring such low resistance levels.



Measuring battery performance and safety

Manufacturing highly safe batteries





High-accuracy OCV measurement

Miniscule voltage

difference

Defect detection

is difficult.

(ocv)

		Hi	gh-accuracy
Model	BT356x series	BT4560	DM7276 (DC VOLTMETER)
Appearance			
Recommended range for 4 V measurement	6 V range	5 V range	10 V range
Number of digit, Max. Display	5 1/2 digit, 6.000 00	5 1/2 digit, 5.100 00	7 1/2 digit, 12.000 000
Resolution*1	10 µV	10 µV	1 µV
Basic accuracy*1	±0.01% rdg ±3 dgt	±0.0035% rdg ±5 dgt	±0.0009% rdg ±12 μV
Measurement error*1 *2	±430 μV	±190 μV	±48 μV
Period of accuracy guarantee	1 year	1 year	1 year
Temperature measurement	N/A	YES	YES
Temperature Compensation Function	N/A	N/A	YES

*1: When using recommended range for 4 V measurement *2: When measuring a 4 V LIB cell

Internal shorts

Insulation defects, which can be caused by factors such as ageing and vibrations during shipment, can lead to fire and other dangerous accidents, making it necessary to check open-circuit voltage values in order to distinguish between defective and non-defective products.

Open-circuit voltage (OCV)

The battery voltage when no load is connected is known as the opencircuit voltage (OCV). When an insulation defect such as an internal short occurs inside the battery, self-discharge causes the open-circuit voltage to decrease

(Dendrite: Metals precipitated dendritic form)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276



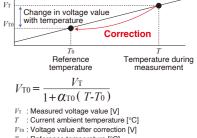
Since the amount of change in OCV caused by self-discharge is extremely small, it is necessary to age batteries at least 100 to 400 hours before testing can accurately distinguish between non-defective and defective products. Additionally, it is necessary to measure OCV multiple times during the aging process. Using an instrument with good accuracy makes it possible to remove defects from the testing line earlier in the process, significantly reducing management and testing costs.

Dendrites form over time as minuscule metal fragment contaminants dissolve, leading to internal shorts.

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560, DM7276

OCV fluctuates with the ambient temperature

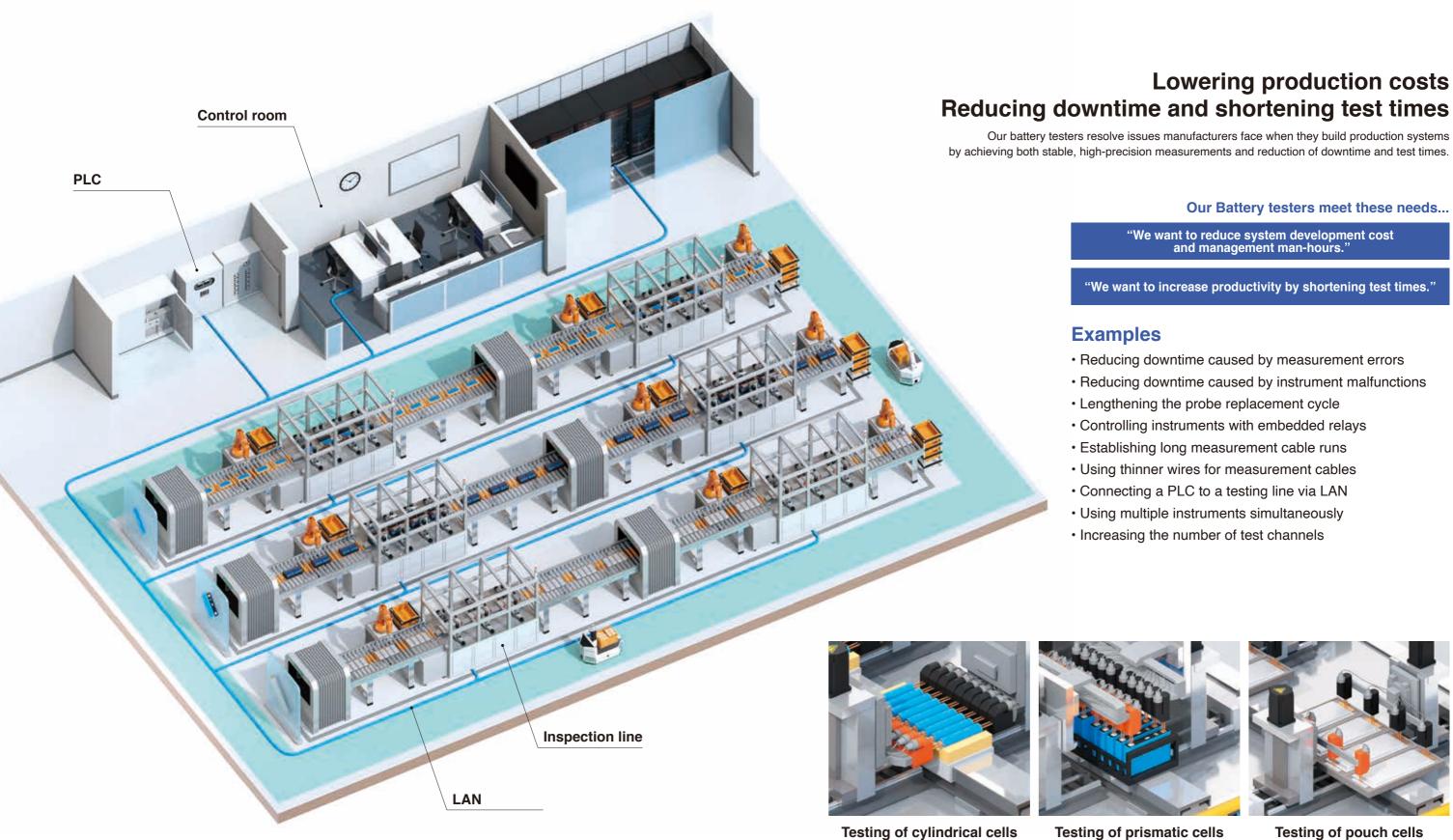
A battery's OCV value can fluctuate several hundred microvolts with a change of just 1°C in the ambient temperature. Temperature correction functionality allows the instrument to display a value that has been converted to the voltage at the reference temperature.



- : Reference temperature [°C] α_{T0} : Temperature coefficient at T_0 [1/°C]

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system



Testing of prismatic cells

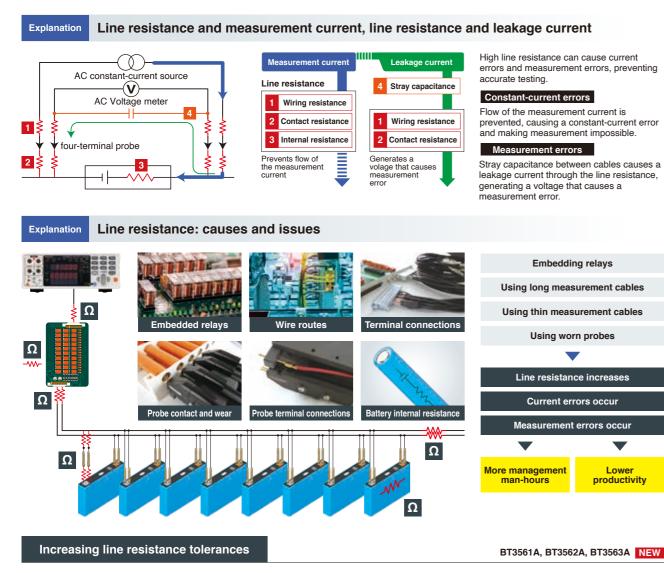
Testing of pouch cells

Acceptance/shipping inspections

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

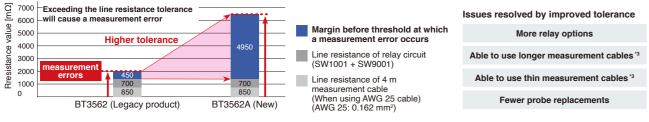
Integrate to automatic testing system

Reducing test system development cost and management man-hours



The new BT356xA has dramatically improved tolerances for line resistance compared to previous models. This improvement makes it easy to build test systems with large numbers of channels using relays. Additionally, a longer maintenance cycle for systems in use means fewer maintenance man-hours. Finally, its capability to handle thinner cables than with previous models⁻³ makes it easier to route cables.

(SENSE side when using 3 m Ω or 30 m Ω range)

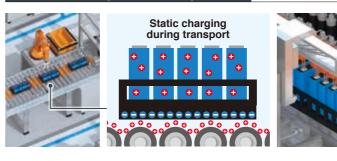


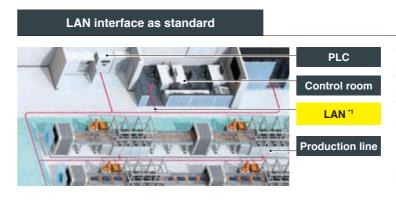
Model	lodel 3561, 3561-01		BT3561A		BT3562A, BT3563A			BT3562-01, BT3563-01, BT3564									
Range		3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω	3 mΩ	30 mΩ	300 mΩ	3Ω
Measurement current		N/A	N/A	10 mA	1 mA	N/A	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA	100 mA	100 mA	10 mA	1 mA
Allowable total line resistance	SENSE line	N/A	N/A	20 Ω	20 Ω	N/A	6.5 Ω	30 Ω	30 Ω	6.5 Ω	6.5 Ω	30 Ω	30 Ω	2Ω	2 Ω	15 Ω	15 Ω
(error detection) *1 *2	SOURCE line	N/A	N/A	50 Ω	500 Ω	N/A	5.5 Ω	15 Ω	150 Ω	5.5 Ω	5.5 Ω	15 Ω	150 Ω	2Ω	2Ω	15 Ω	150 Ω

*1: Typical value *2: Total line resistance = (Wiring resistance + Contact resistance + DUT resistance)

*3: AWG 29 (0.064 mm²) wire equivalent to 2.2 Ω over an 8 m round trip can be used with the 3 m Ω or 30 m Ω range.

Preventing instrument malfunctions caused by static electricity

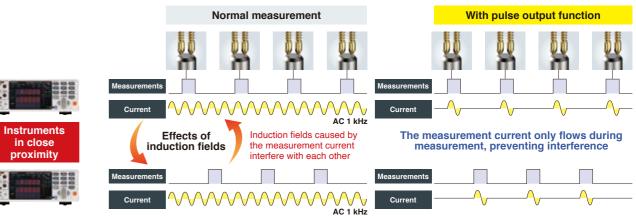






Using multiple instruments simultaneously

When multiple battery testers are used at the same time, their induction fields can interfere with each other, causing measurement errors. Since the instruments' measurement currents flow continuously, such interference can occur even if measurements are timed so that they don't occur simultaneously. The measurement current pulse output function allows the measurement current to flow only during measurement. By using this function to make alternating measurements, you can avoid the effects of interference between induction fields caused by the measurement current.



BT3561A, BT3562A, BT3563A NEW



Batteries can become charged on production lines, for example, when being transported on a conveyor belt. When probes are placed in contact with such batteries, the resulting application of static electricity can then damage the instrument. The BT356xA series is designed to withstand contact with ± 30 kV of static electricity*, preventing static-caused malfunctions and reducing testing line downtime.

* ±30 kV IEC 61000-4-2 contact discharge

BT3561A, BT3562A, BT3563A NEW

The BT356xA series is equipped with a LAN interface as standard equipment, making it easy for the instrument to interoperate with a PLC²-based control system. The ability to use readily accessible LAN cables helps lower costs during system development and maintenance. Furthermore, a design with strong noise and static electricity resistance helps avoid system problems.

*1: Max.30 m *2: Programmable Logic Controller, a device that automatically controls one or more machines

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

OK

Accurate probing is essential for accurate measurement. Our battery testers are equipped with probe contact monitoring functionality to ensure highly reliable testing.

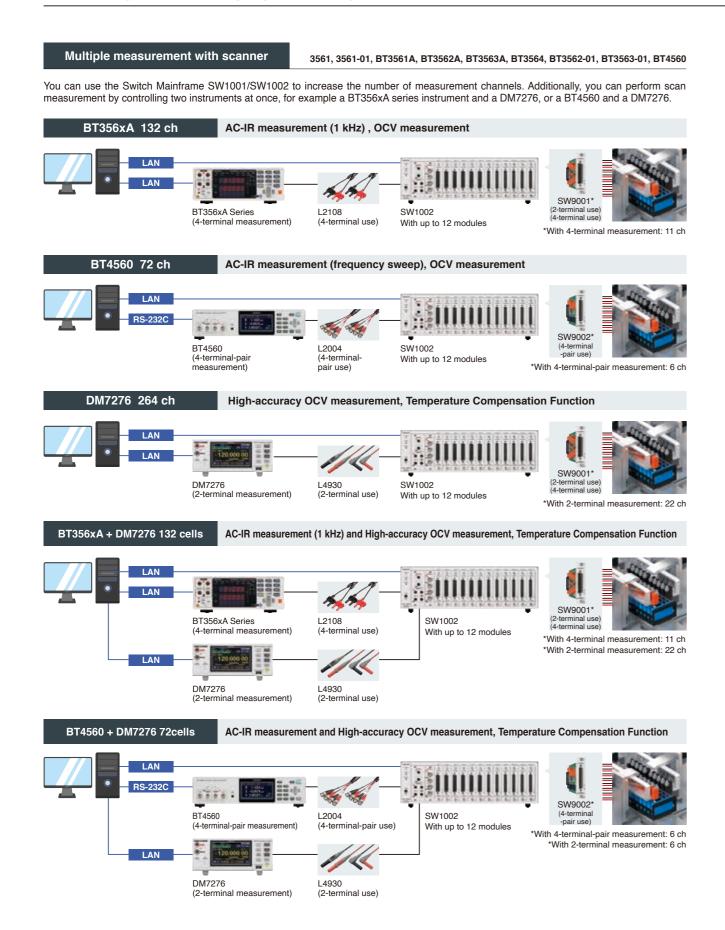
BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

14

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3564, BT3562-01, BT3563-01, BT4560

Integrate to automatic testing system

Improving productivity by reducing test times



Configuration Example of Multi-channel Battery Testing

Number of instruments in use	AC-IR measurement 1 kHz	AC-IR measurement frequency sweep	OCV measurement	High-accuracy OCV measurement Temperature Compensation Function	Connection cable	Switch mainframe	Module	Maximum number of channels
1	YES	N/A	YES	N/A	L2108	SW1002	SW9001	132 ch
1	YES	YES	YES	N/A	L2004	SW1002	SW9002	72 ch
1	N/A	N/A	N/A	YES	L4930	SW1002	SW9001	264 ch
2	YES	N/A	YES	N/A	L2108	SW1002	SW0001	100 ob
(switched)	N/A	N/A	N/A	YES	L4930	instrument	500001	132 ch
2	YES	YES	YES	N/A	L2004	SW1002	014/0000	72 ch
(switched)	N/A	N/A	N/A	YES	L4930	instrument	5009002	72 CN
	instruments in use 1 1 1 (switched) 2	instruments in use 1 YES 1 YES 1 YES 1 N/A 2 (switched) A YES N/A YES 2 YES	instruments in use measurement 1 kHz measurement frequency sweep 1 YES N/A 1 YES YES 1 N/A N/A 2 (switched) YES N/A 2 YES N/A 2 YES N/A 2 YES YES 2 YES YES	instrumentsmeasurement 1 kHzmeasurement frequency sweepCCV measurement1YESN/AYES1YESYESYES1N/AN/AN/A2 (switched)YESN/AYES2 (switched)YESYESYES	Number of instruments AC-In trequency sweep OCV measurement measurement OCV measurement OVV OVV <t< td=""><td>Number of in struments in usesActine measurement trequency sweepOCV measurement measurement measurementOCV measurement Temperature Compensation FunctionConnection cable1YESN/AYESN/AL21081YESYESYESN/AL20041N/AN/AN/AYESL49302 (switched)YESN/AN/AL21080YESYESYESL49302 (switched)N/AN/AN/AYES1YESYESN/AL2004</td><td>Number of in struments in useAccin measurement frequency sweepAccin measurement frequency sweepOCV measurement measurement measurement measurement Compensation FunctionConnection cableSwitch mainframe1YESN/AYESN/AL2108SW10021YESYESYESN/AL2004SW10021N/AN/AN/AYESL4930SW10021N/AN/AYESN/AL2108SW10022 (switched)YESN/AYESN/AL2108SW10022 (switched)YESN/AN/AYESSW1002Switching instrument2 (switched)YESYESYESYESSW1002Switching switching2 (switched)YESYESYESYESSW1002 Switching</td><td>Number of in struments in usesAC-In measurement frequency sweepAC-In measurement frequency sweepOCV measurement measurement measurement Compensation FunctionConnection cableSwitch mainframeModule1YESN/AYESN/AL2108SW1002SW90011YESYESYESN/AL2004SW1002SW90021N/AN/AN/AYESL4930SW1002SW90012 (switched)YESN/AYESN/AL2108SW1002 SW1002SW90012 (switched)YESN/AYESN/AL2108SW1002 Switching instrumentSW90012 (switched)YESYESYESN/AL2108SW1002 Switching instrumentSW90012 (switched)YESYESYESYESSW9001SW9001</td></t<>	Number of in struments in usesActine measurement trequency sweepOCV measurement measurement measurementOCV measurement Temperature Compensation FunctionConnection cable1YESN/AYESN/AL21081YESYESYESN/AL20041N/AN/AN/AYESL49302 (switched)YESN/AN/AL21080YESYESYESL49302 (switched)N/AN/AN/AYES1YESYESN/AL2004	Number of in struments in useAccin measurement frequency sweepAccin measurement frequency sweepOCV measurement measurement measurement measurement Compensation FunctionConnection cableSwitch mainframe1YESN/AYESN/AL2108SW10021YESYESYESN/AL2004SW10021N/AN/AN/AYESL4930SW10021N/AN/AYESN/AL2108SW10022 (switched)YESN/AYESN/AL2108SW10022 (switched)YESN/AN/AYESSW1002Switching instrument2 (switched)YESYESYESYESSW1002Switching switching2 (switched)YESYESYESYESSW1002 Switching	Number of in struments in usesAC-In measurement frequency sweepAC-In measurement frequency sweepOCV measurement measurement measurement Compensation FunctionConnection cableSwitch mainframeModule1YESN/AYESN/AL2108SW1002SW90011YESYESYESN/AL2004SW1002SW90021N/AN/AN/AYESL4930SW1002SW90012 (switched)YESN/AYESN/AL2108SW1002 SW1002SW90012 (switched)YESN/AYESN/AL2108SW1002 Switching instrumentSW90012 (switched)YESYESYESN/AL2108SW1002 Switching instrumentSW90012 (switched)YESYESYESYESSW9001SW9001



(Interval setting: 1 second to 60 minutes)

SW1002

```
Recording results with 
a dedicated PC application
                                                                                   Address and seath and
        ----
                        R 131208-000 0 R 131278-000 0
                                           131718-003 9
                                                            1.00. 0
     14708-300 9
     127906-001 0
3 999095-009 V
                                                          12101E-000 9 H 1270E-000 9
                                           1 30465-000 Q
     12
127278-003 Q A 129786-003 Q
3459422-000 V V 3696072-000 V
                                           1 32965-003 D
                                                            Silano
Silano
    HIE CHIEF-000 0 CHIEF

129408-000 0 V 129198-000 0 H 129198-000 0

12940828-000 V 1 129198-000 0 V 1 129198-000 0
    PUT 129478-000 0 R 128428-000 0 R 129158-000 0 3581148-000 V 2 2580278-000 V 2 2580278-000 V
   -
                                                                                                         10.00
   -
                                                               .....
                                                                                             1/1. person
                 -----
                                                12.1
Logging function
```

Cycle time for measurement completion Basic connection 1. Communication time example Start switching channels Finish switching channels Channel switch ing time (11 ms) Cycle time calculation Channel switching time Total time Communication tim

Instrument	Module	Number of channels	Function	Measurement speed	Measur
BT3562A	SW9001	11	QV	EX. FAST	10 ו
D13302A	309001	11	1 120	MEDIUM	10 1
		6		FAST	0 n
BT4560	SW9002	6	RX	MEDIUM	0 n
		22		0.02 PLC*	0 n
DM7276	SW9001	22	V	FAST	0 n
		22		MEDIUM	0 n
*Power Line Cu	icle 20 ms at 50) Hz 167 ms at	60 Hz		

*Power Line Cycle 20 ms at 50 Hz, 16.7 ms at 60 Hz







SW1002: accomodates up to 12 SW9001 or SW9002 modules SW1001: accomodates up to 3 SW9001 or SW9002 modules SW9001 (2-terminal use, 4-terminal use), SW9002 (4-terminal-pair use)

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



Multichannel Nyquist or Cole-Cole plot

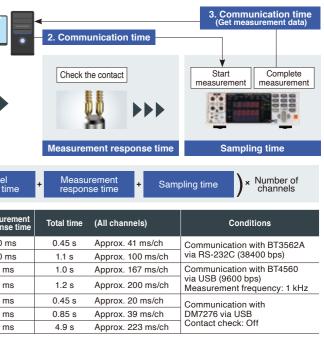
Logging function

Measure and log up to 264 channels.

OCV measurement function Measure OCVs, and additionally record the initial voltages and change rates as well.

Multichannel Nyquist or Cole-Cole plot Measure impedance while varying the frequency across up to 72 channels and display the results as a Nyquist or Cole-Cole plot. *PC application for SW1001/SW1002.

3561, 3561-01, BT3561A, BT3562A, BT3563A, BT3562-01, BT3563-01, BT4560, DM7276



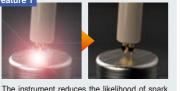
Internal resistance and open-circuit voltage for various battery types and compatible instruments



Testing high-voltage battery packs safely



The BT3564 can safely test high-voltage battery packs such as infrastructure storage batteries.



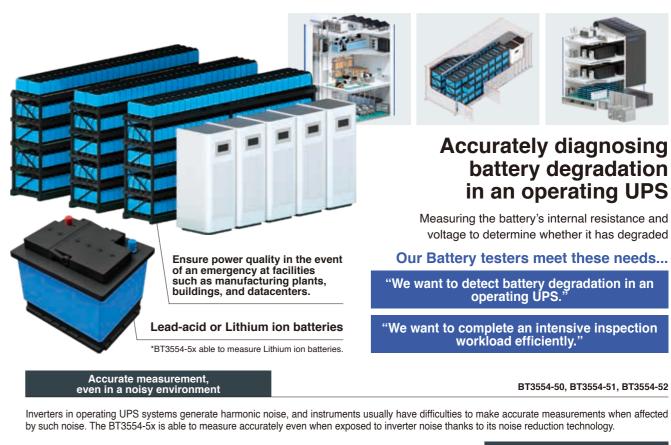
discharges, which are prone to occur during high-voltage measurement, by limiting the amount of current that flows the instant contact is established with a battery pack.

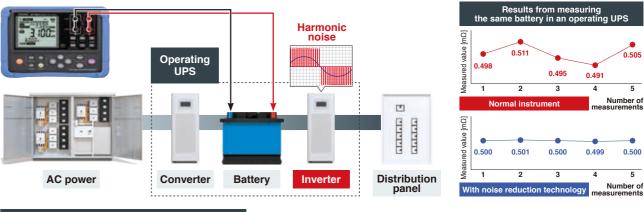


The optional L2110 probe, which is designed specifically for use with the BT3564, can make measurements safely thanks to its 1000 V withstand voltage. Additionally, the probe is designed to accommodate battery packs whose terminals are placed far apart.

Diagnosing degradation in batteries

BT3554-50, BT3554-51, BT3554-52





Completing an intensive inspection workload efficiently

You can efficiently inspect an enormous number of batteries, for example those found in UPS systems, with our free app "GENNECT Cross"



Up to 100 sets of profile information can be registered on the BT3554-5x. Up to 500 data sets can be saved for each profile. (The BT3554-5x can save up to 6,000 data sets.)

To use GENNECT Cross, you must install the Wireless Adapter Z3210 (sold separately) and the GENNECT Cross app on your device. Profile information can be registered on the BT3554-50 from either GENNECT Cross or the desktop application GENNECT ONE.

battery degradation in an operating UPS

voltage to determine whether it has degraded

BT3554-50, BT3554-51, BT3554-52

Analyzing batteries BT4560

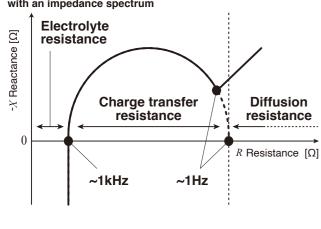


The chemical reactions in batteries involve several processes and each process has its own reaction speed. Therefore by sweeping the

Assessing battery characteristics

frequency and measuring the impedance the characteristics of each part can be evaluated separately.

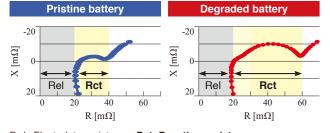
Drawing a Nyquist or Cole-Cole plot with an impedance spectrum



Check the battery deterioration level

The resistance of a degraded battery is significantly larger than a pristine one. The degradation of charge transfer resistance is particularly noticeable in the Nyquist or Cole-Cole plot for applications that involve charging/discharging at low temperatures or deep charging/discharging (SOC between 0% and 100%)

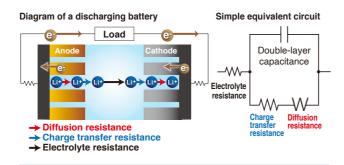




Rel: Electrolyte resistance Rct: Reaction resistance

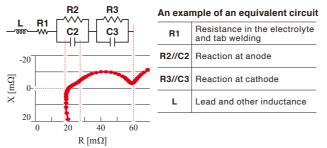
less than 1 Hz	Low frequencies	Li-ion diffusion in the electrode (Diffusion resistance)
1 Hz to several hundred Hz		Li-ion transfer (Charge transfer resistance)
About 1 kHz	High frequencies	Li-ion transport in electrolyte (electrolyte resistance)

BT4560



Idenfity battery deterioration factors

An equivalent circuit analysis software (e.g. ZView®*) can provide the parameters of each element of an equivalent circuit model by means of curve fitting. It allows you to see which part of the battery has shown characteristic changes. This serves to identify battery deterioration factors.



*ZView® is a product of Scribner Associates, Inc.

For more information about ZView®, please contact Scribner Associates, Inc.

surement frequencies and nce i

The BT4560 offers measurements in the optimal frequency range for liquid Li-ion batteries. Its unparalleled capability to measure extremely low impedance is ideal for large cells such as ones for xEVs or ESSs. As a complementary instrument, the IM3590 offers npedance.

mpedance measurements across a wider frequency range. It is very capable at measuring larger im								
Model		Measurement frequency Impedance Max. Woltage						
IM3590	1 mH	lz to 2	00 kHz			100 mΩ to 100 MΩ	5 V	
BT4560 (Special specifications for 10 kHz)		0.01	Hz to 10 kHz			3 mΩ, 10 mΩ, 100 mΩ	5 V	
BT4560 (Standard specification)			0.1 Hz to 1050 Hz			3 mΩ, 10 mΩ, 100 mΩ	5 V	
BT4560 (Special specifications 1)			0.1 Hz to 1050 Hz			30 mΩ, 300 mΩ	10 V	
BT4560 (Special specifications 2)			0.1 Hz to 1050 Hz			30 mΩ, 300 mΩ, 3 Ω	20 V	
BT4560 (Special specifications 3)		0.01	Hz to 1050 Hz			3 mΩ, 10 mΩ, 100 mΩ	5 V	
BT4560 (Special specifications 4)		0.01	Hz to 1050 Hz			30 mΩ, 300 mΩ	10 V	
BT4560 (Special specifications 5)		0.01	Hz to 1050 Hz			30 mΩ, 300 mΩ, 3 Ω	20 V	

BT4560 Accuracy specifications

Impedance measurement accuracy

		e (0.1 Hz to 100 Hz) je, 100 mΩ range	$3 \text{ m}\Omega$ range (110) Hz to 1050 Hz)
X at Z at θ at C Imp (0.0	$\begin{array}{l} ccuracy = \\ ccuracy = \\$	-90 0 90 Phase [e accuracy excluding <i>a</i> 0.0017 X , 0.004 X + 0.0017 R	$\begin{array}{c} 1 \pm \alpha \ \ X \ \text{accuracy} = \pm (0.0 \ \ Z \ \ \text{accuracy} = \pm 0.4^{\circ} \ \ \theta \ \ \ \text{accuracy} = \pm 0.4^{\circ} \ \ \theta \ \ \ \text{accuracy} = \pm 0.4^{\circ} \ \ \theta \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ $	004 X + 0.0052 I % rdg ±a (sin θ + ° ±57.3 $\frac{\pi}{2}$ (sin θ + R 0 9 suracy excluding
		f R and X are $[m\Omega]$, α is as s 3 m Ω	nown below 10 mΩ	100 mΩ
	Range FAST	25 dgt	60 dgt	60 dgt
α	MED	15 dgt	30 dgt	30 dgt
u	SLOW	8 dgt	15 dgt	15 dgt
	01011	0 491	10 491	10 ugi

JUCIN	0 uyi	15 ugi	15 ug
	$R: \pm R$ accuracy × 0.1 / °C, $X: = \theta: \pm \theta$ accuracy × 0.1 / °C (App		

Measurement probes and specialized jigs



*1: See pages 22 and 23 for compatible probes

*2: Special-order product. *3: Used when combining the BT4560 with the SW1001/SW1002 and SW9002.

BT4560, IM3590

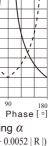


CHEMICAL IMPEDANCE ANALYZER



BT4560 BATTERY IMPEDANCE METER

|X|) [m Ω] $\pm \alpha$ |R|) [m Ω] $\pm a$ $|\cos\theta|$ $|\cos\theta|$



Voltage measurement accuracy (when self-calibration is performed)

V	Display range	-5.10000 V to 5.10000 V
v	Resolution	10 µV
Voltage accuracy	FAST/MED/SLOW	±0.0035% rdg ±5 dgt
Temperature coefficient	0 0	µt / °C f 0°C to 18°C and 28°C to 40°C)

Temperature measurement accuracy

(BT4560 + Z2005 temperature sensor)

Accuracy	±0.5°C (measurement temperature: 10.0°C to 40.0°C) ±1.0°C (measurement temperature: -10.0°C to 9.9°C, 40.1°C to 60.0°C)
Temperature coefficient	$\pm 0.01^{\circ}\text{C}/^{\circ}\text{C}$ (applied in the ranges of 0°C to 18°C and 28°C to 40°C)

The number of waveforms

	FAST	MED	SLOW
0.10 Hz to 66 Hz	1 wave	2 waves	8 waves
67 Hz to 250 Hz	2 waves	8 waves	32 waves
260 Hz to 1050 Hz	8 waves	32 waves	128 waves

0°C)

Cables are also available on a special-order basis Please contact HIOKI for more information

Test fixture for cylindrical batteries to use with the Pin Type Probe L2003

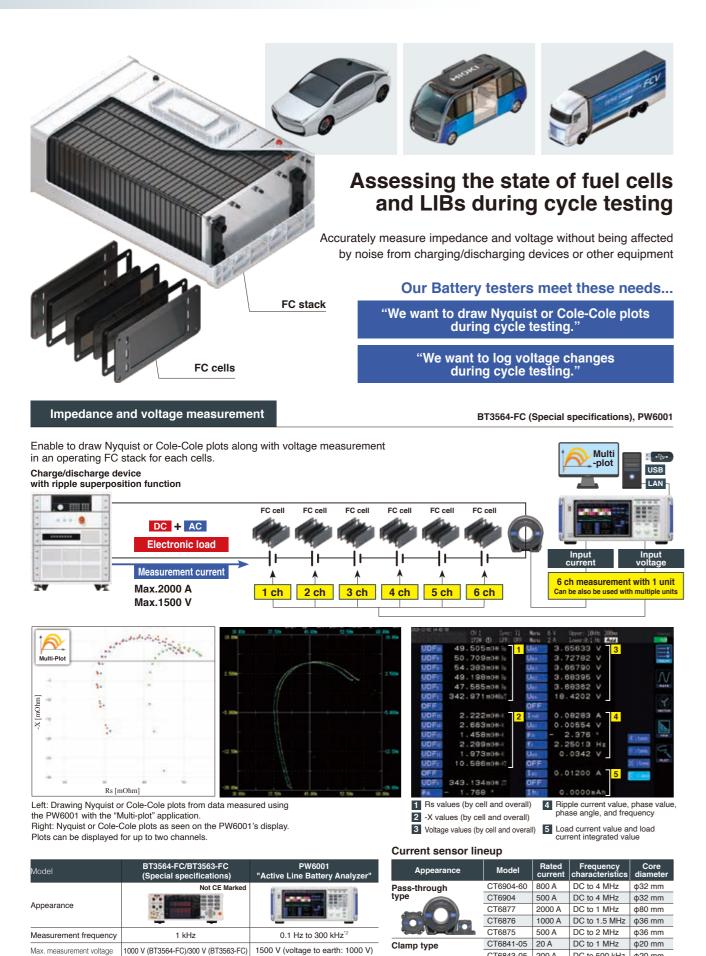




For securing 1 cell'2"3 For securing up to 6 cells'2"3 With batteries attached Connection cord '2"3 (Accommodates 18650, 21700, 4680 and 26650 size cells.)

Analyzing fuel cells (FCs)

BT3564-FC (Special specifications), PW6001



CT6843-05 200 A

DC to 500 kHz φ20 mm

CT6844-05 500 A DC to 200 kHz \$\phi20 mm\$

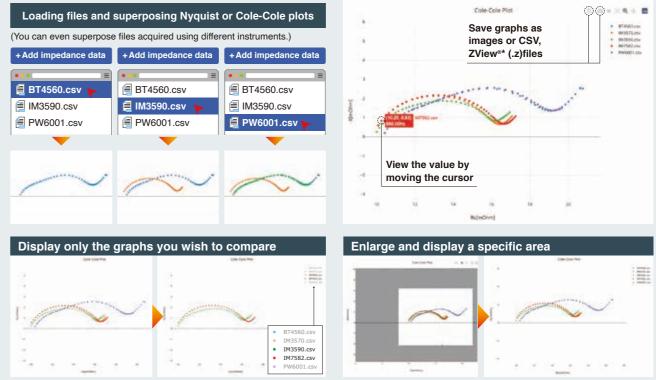
CT6845-05 500 A DC to 100 kHz 050 mm

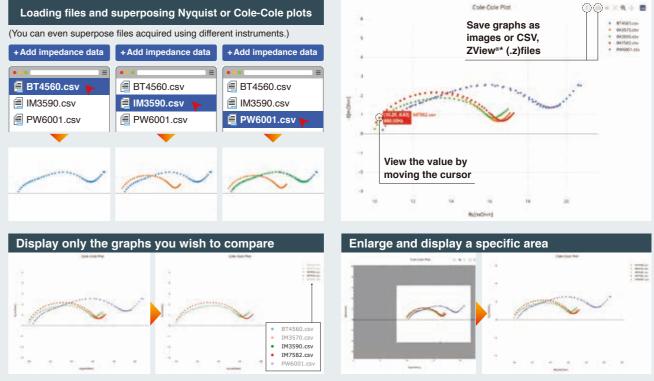
CT6846-05 1000 A DC to 20 kHz 050 mm

HIOKI Hung Malighe Shared -00 A Multi-plot (Beta) Multi-plot and gives given 回熟的回 - 5 争 HIOK



Draw Nyquist or Cole-Cole plots freely, without any limits on the number of points that can be rendered from files or the number of graphs that can be superposed. The horizontal and vertical axes are automatically scaled based on the graphs being rendered. You can even superpose, compare, and analyze files acquired using different instruments





Analysis function

Conduct an equivalent circuit analysis phase characteristics Nyquist or Cole-Cole plot Fitting Me Rs[mOhm] rmse_score[Ohm] : 6.93e-5 R0[Ohm] : 9.17e-3 L3[H] : 1.07e-7 R3[Ohm] : 1.00e+1 Model : R0-(L3//R3)-(CPE1//R1)-(CPE2//R2)-W1 L3 CPE1 CPE2 →≻┓┍╱┑┉ CPE1 Q[Ohm^-1 sec^p] : 3.25e+0 CPE1_p[]: 6.01e-1 R1[Ohm]: 7.57e-3 R1[Ohm]: /.5/e-3 CPE2_Q[Ohm^-1 sec^p]: 3.35e+2 CPE2_p[]: 1.00e+0 R2[Ohm]: 3.13e-3 W1_R[Ohm]: 1.98e-5 W1_T[sec]: 5.00e+0 $ZCPE = \frac{1}{(j2\pi f)^p Q}$ $ZW = \frac{R}{\sqrt{j2\pi fT}} \operatorname{coth} \sqrt{j2\pi fT}$

Analyze the data with predefined models. Display analysis results automatically assess phase characteristics. simply by loading a file.

1 ch to 6 ch (× Number of units in use) 1 ch *1: The number of channels can be increased using the SW1001/SW1002. (Maximum allowable voltage: 60 V DC) *2: Plans to support 0.01Hz

Not specified

2000 A

Max. allowable input current

Number of channels

Web application "Multi-plot"

Converting measurement data into a Nyquist or Cole-Cole plot

web browser link

https://www.circuitfitting.net/multiplot

"Multi-plot", a free web application, enables you to draw

a Nyquist or Cole-Cole plot simply by loading a file in your web browser. Supported files: CSV file, ZView®* (.z) file

Supported instruments: BT4560, PW6001, IM3536, IM3570, IM3590, IM758x

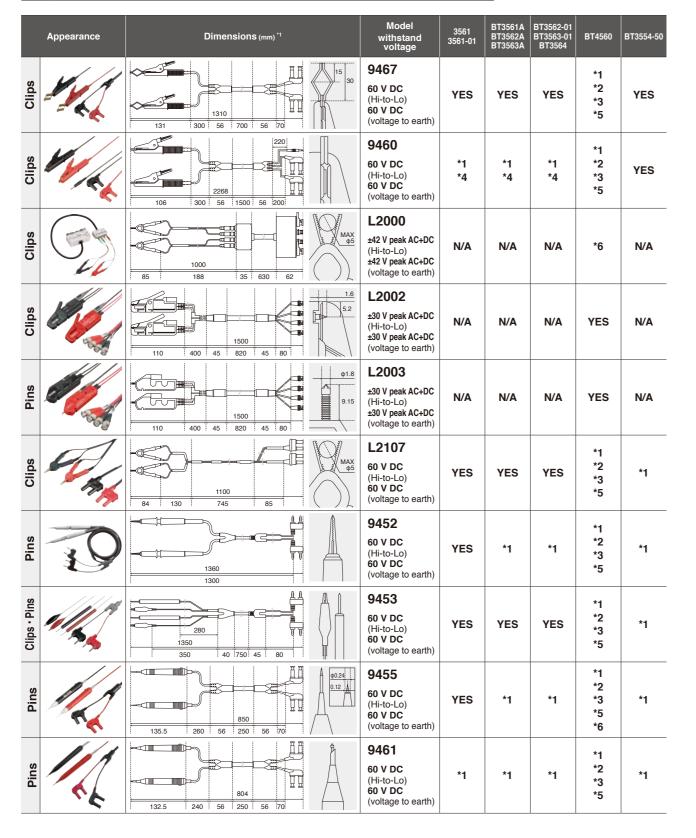


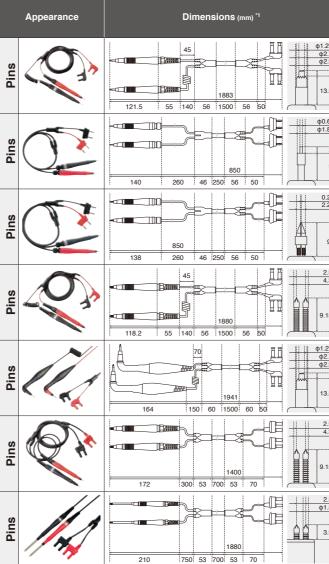
Draw Bode plots to assess Analyze characteristics with 3D view Both Hall for any 101.4 Rotate the graph in 3D -Bode plots are also drawn, enabling to Draw 3D Nyquist or Cole-Cole plots or 3D

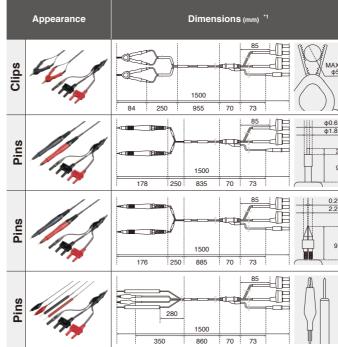
Bode plots, using the time or date as a third axis. Rotate 3D graphs in any direction as desired and save images.

Measurement lead and measurement probe compatibility chart

- YES : Recommended measurement lead or measurement probe listed in brochures.
- N/A : Not compatible due to inability to connect. *1 : Not subject to accuracy guarantee.
- May be susceptible to external noise. *2 Caution is particularly required when using a measurement current of 10 mA or less
- BNC banana plug adapter (See page 19) *3
- Connect the black banana plugs to the HCUR and HPOT terminals to reduce the influence from external noise
- *4 : Temperature sensor cannot be connected.
- *5 : It does not use a 4-terminal-pair design, so wiring placement will have a greater effect on measured values.
- *6 : Some measurement ranges cannot be used due to rated current limitations.







*1: Dimensions other than overall length include typical values. *2: HIOKI recommends measurement leads without separate guard terminals: L2101 - L2107, L2102 - 9770, L2103 - 9771, L2104 - 9453

	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
27	9465-10 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
.6 .8 2 9	9770 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
9	9771 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	YES	YES	YES	*1 *2 *3 *5	*1
15	9772 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
27	L2020 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*1	*1	*1	*1 *2 *3 *5	YES
15	L2100 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	*2 *3 *5	*2
.5	L2110 1000 V DC (Hi-to-Lo) 1000 V DC (voltage to earth)	*1	YES	YES	N/A	N/A

	Model withstand voltage	3561 3561-01	BT3561A BT3562A BT3563A	BT3562-01 BT3563-01 BT3564	BT4560	BT3554-50
	L2101 ^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
.6 .8 2 9	L2102*2 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
9	L2103 ^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2
	L2104^{*2} 60 V DC (Hi-to-Lo) 60 V DC (voltage to earth)	*2	*2	*2	*2 *3 *5	*2

Batteries are a driving force for a variety of innovations as we move towards a sustainable society

Batteries are used in an array of applications, and their performance can be a driving force for a variety of innovations and new lifestyles. The development and production of high-quality batteries will play an essential role as we work to realize a sustainable society. At the same time therefore, growing improvements in battery life cycle assessment have become a major priority. the focus on reducing CO2 emissions throughout the entire life cycle by means of improvements in manufacturing processes and reuse of high-quality batteries is increasing. HIOKI battery testers are helping resolve these issues through an electrical measurement approach.

Stacked battery voltage, Internal resistance of battery cells



Scan for all regional contact